

LIST OF ART CITED BY APPLICANT

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Eun-Jeong CHOI

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
	2001/0042081	11/15/2001	Macfarlane et al.			
	2005/0056444	12/27/2001	Ide et al.			

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	WO 02/052785	07/04/2002	WIPO			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

	European Search Report dated March 30, 2010.
	Appendix A: HDML 2.0 BNF Summary; Anonymous; May 9, 1997; XP002571638; Retrieved from the Internet: URL:http://www.w3.org/TR/hdml120-8.html ; pages 1-3
	The Complete WML DTD; Anonymous; 1999; XP002571693; Retrieved from the Internet; URL:http://www.w3schools.com/wap/wml_dtd.asp ; pages 1-8
	21 Document Type Definition ; Raggett D et al.; December 24, 199, XP002571640 Retrieved from the Internet ; URL: http://www.w3.org/TR/REC-htm140/sgml/dtd.html ; pages 1-14

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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